

Search Notes**Application/Control No.**

10/633,145

Examiner

MARK BLOUIN

**Applicant(s)/Patent under
Reexamination**

CHANG ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search		12/2/2010	MB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Search	12/2/2010	MB